## Notice of References Cited Application/Control No. 10/591,802 Examiner Marcus Charles Applicant(s)/Patent Under Reexamination SHIBAHARA ET AL. Art Unit Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,363,003 A	11-1994	Harada et al.	310/67R
*	В	US-5,750,616 A	05-1998	Shimpuku et al.	524/496
*	C	US-6,284,831 B1	09-2001	Shimpuku et al.	524/494
*	D	US-2003/0164653 A1	09-2003	Yasuda, Hisafumi	310/90
*	Е	US-6,756,715 B2	06-2004	Hirose et al.	310/90
*	F	US-6,832,853 B2	12-2004	Fujinaka, Hiroyasu	384/100
*	G	US-6,851,859 B2	02-2005	Takehana et al.	384/100
*	Ι	US-7,023,119 B2	04-2006	Doemen, Benno	310/90.5
	-	US-			
	J	US-			
	K	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 05338097 A	12-1993	Japan	TANIGUCHI et al.	B32B 27/20
	0	JP 11117935 A	04-1999	Japan	TANAKA et al.	F16C 17/10
	Р	JP 2002226713 A	08-2002	Japan	WADAHARA et al.	C08L101/00
	Q	WO 2062899 A1	08-2002	World Intellect	WADAHARA et al.	C08L101/00
	R					
	S					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	C	
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	W	
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.